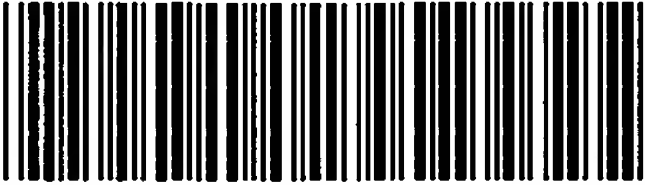


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,417	MOTOYAMA, HAJIME	
	Examiner	Art Unit	
	Hai C. Pham	2861	

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	248		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Text Search	9/23/2005	HP
EAST Text Search	9/30/2005	HP